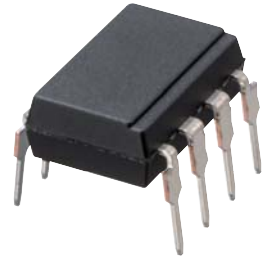


PC925L0NSZ0F Series

High Speed, 2.5A Output,
Gate Drive DIP 8 pin
*OPIC Photocoupler



■ Description

PC925L0NSZ0F Series contains a LED optically coupled to an OPIC chip.

It is packaged in a 8 pin DIP, available in SMT gullwing lead form option.

Peak output current is 2.5A, Input-output isolation voltage(rms) is 5kV and High speed response (t_{PHL} , t_{PLH} : MAX. 0.5 μ s).

■ Features

1. 8 pin DIP package
2. Double transfer mold package
(Ideal for Flow Soldering)
3. Built-in direct drive circuit for MOSFET / IGBT drive
($I_{O(peak)}$: 2.5A)
4. High speed response (t_{PHL} , t_{PLH} : MAX. 0.5 μ s)
5. Wide operating supply voltage range
(V_{CC} =15 to 30 V)
6. High noise immunity due to high instantaneous common mode rejection voltage (CM_H : MIN. -15kV/ μ s, CM_L : MIN. 15kV/ μ s)
7. Long creepage distance type (wide lead-form type only : MIN. 8mm)
8. High isolation voltage between input and output
($V_{iso(rms)}$: 5kV)
9. RoHS directive compliant

■ Agency approvals/Compliance

1. Recognized by UL1577 (Double protection isolation), file No. E64380 (as model No. **PC925L**)
2. Package resin : UL flammability grade (94V-0)
3. Compliant with RoHS directive (2002/95/EC)
4. Content status of six substances specified in
"Management Methods for Control of Pollution Caused by Electronic Information Products Regulation"
(Chinese : 电子信息产品污染控制管理办法)
(popular name : China RoHS)
; refer to page 16

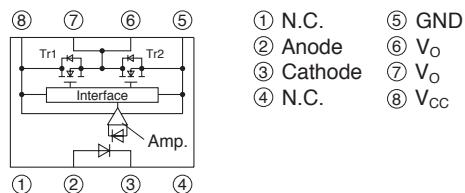
■ Applications

1. IGBT/MOSFET gate drive for inverter control

* "OPIC"(Optical IC) is a trademark of the SHARP Corporation. An OPIC consists of a light-detecting element and a signal-processing circuit integrated onto a single chip.

Notice The content of data sheet is subject to change without prior notice.
In the absence of confirmation by device specification sheets, SHARP takes no responsibility for any defects that may occur in equipment using any SHARP devices shown in catalogs, data books, etc. Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device.

Internal Connection Diagram



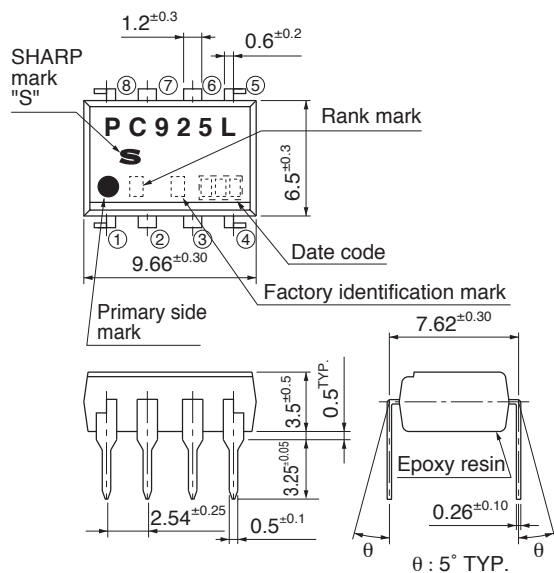
Truth table

Input	V _O Terminal output	Tr1	Tr2
ON	High level	ON	OFF
OFF	Low level	OFF	ON

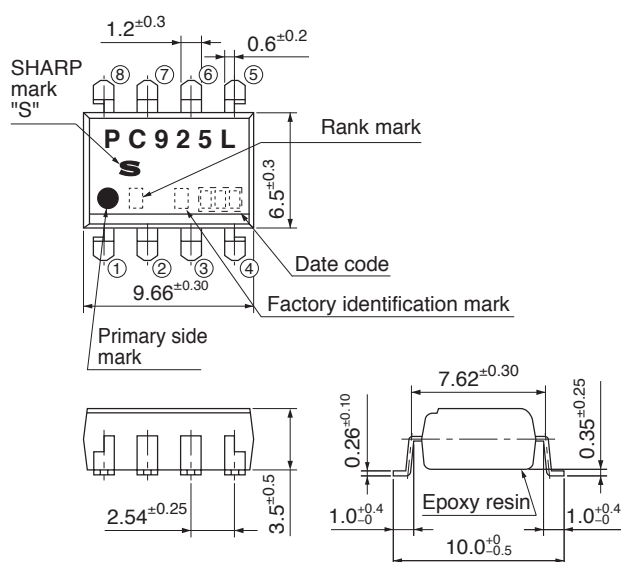
Outline Dimensions

(Unit : mm)

1. Through-Hole [ex. PC925L0NSZ0F]

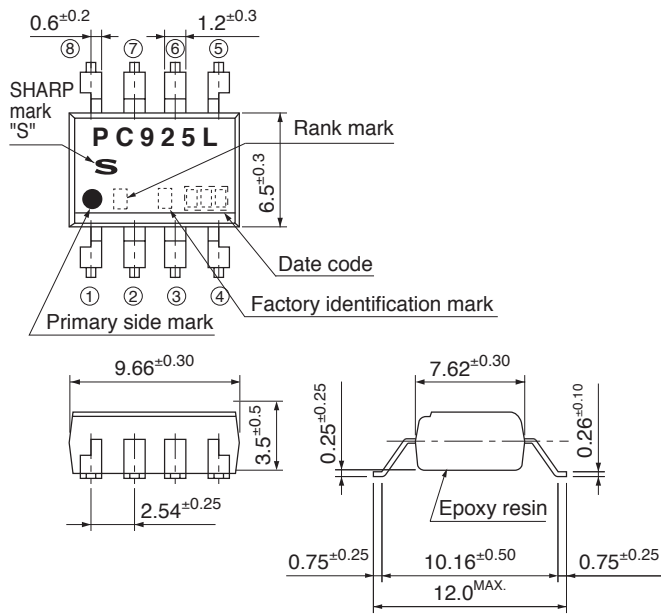


2. SMT Gullwing Lead-Form [ex. PC925L0NIP0F]



(Unit : mm)

3. Wide SMT Gullwing Lead-Form [ex. PC925L0NUP0F]



Product mass : approx. 0.55g

Plating material : Pd (Au flash)

Date code (3 digit)

1st digit				2nd digit		3rd digit	
Year of production				Month of production		Week of production	
A.D.	Mark	A.D.	Mark	Month	Mark	Week	Mark
1990	A	2002	P	January	1	1st	1
1991	B	2003	R	February	2	2nd	2
1992	C	2004	S	March	3	3rd	3
1993	D	2005	T	April	4	4th	4
1994	E	2006	U	May	5	5, 6th	5
1995	F	2007	V	June	6		
1996	H	2008	W	July	7		
1997	J	2009	X	August	8		
1998	K	2010	A	September	9		
1999	L	2011	B	October	O		
2000	M	2012	C	November	N		
2001	N	:	:	December	D		

repeats in a 20 year cycle

Factory identification mark

Factory identification Mark	Country of origin
no mark	Japan
	
 or 	Indonesia
 or 	China

* This factory marking is for identification purpose only.
Please contact the local SHARP sales representative to see the actual status of the production.

Rank mark

With or without.

■ Absolute Maximum Ratings (T_a=25°C)

	Parameter	Symbol	Rating	Unit
Input	*1 Forward current	I _F	25	mA
	Reverse voltage	V _R	5	V
	*2 Peak forward current	I _{FM}	1	A
Output	Supply voltage	V _{CC}	35	V
	*3 Peak output current	I _{O(PEAK)}	2.5	A
	Output voltage	V _O	V _{CC}	V
	*4 Output power dissipation	P _O	250	mW
	*5 Total power dissipation	P _{tot}	295	mW
	*6 Isolation voltage	V _{iso(rms)}	5	kV
	Operating temperature	T _{opr}	−40 to +100	°C
	Storage temperature	T _{stg}	−55 to +125	°C
	*7 Soldering temperature	T _{sol}	270	°C

*1 When ambient temperature goes above 70°C, the power dissipation goes down at 0.3mA/°C (Refer to Fig.10).

*2 Pulse width ≤ 1μs, 300pps

*3 Pulse width ≤ 10μs, Duty ratio : 0.002

*4 When ambient temperature goes above 70°C, the power dissipation goes down at 4.8mA/°C (Refer to Fig.11).

*5 When ambient temperature goes above 70°C, the power dissipation goes down at 5.4mA/°C (Refer to Fig.12).

*6 AC for 1min, 40 to 60%RH, f=60Hz

*7 For 10s

■ Electro-optical Characteristics ^{*8}

(Unless otherwise specified : $T_a = -40$ to $+100^\circ\text{C}$, $I_{F(ON)} = 7$ to 16mA , $V_{CC} = 15$ to 30V , $V_{F(OFF)} = -3\text{V}$ to 0.8V)

	Parameter	Symbol	Condition	MIN.	^{*13} TYP.	MAX.	Unit
Input	Forward voltage	V_F	$I_F = 10\text{mA}$	1.2	–	1.8	V
	Reverse current	I_R	$V_R = 5\text{V}$	–	–	10	μA
	Terminal capacitance	C_t	$T_a = 25^\circ\text{C}$, $V = 0$, $f = 1\text{MHz}$	–	60	150	pF
Output	High level output current	I_{OH}	^{*8} $V_O = (V_{CC} - 4\text{V})$, $I_{F(ON)}$	0.5	1.5	–	A
			^{*9} $V_O = (V_{CC} - 15\text{V})$, $I_{F(ON)}$	2	–	–	A
	Low level output current	I_{OL}	^{*8} $V_O = 2.5\text{V}$, $V_{F(OFF)}$	0.5	2.0	–	A
			^{*9} $V_O = 15\text{V}$, $V_{F(OFF)}$	2	–	–	A
	High level output voltage	V_{OH}	$I_O = -0.1\text{A}$, $I_{F(ON)}$	$V_{CC} - 4$	$V_{CC} - 3$	–	V
	Low level output voltage	V_{OL}	$I_O = 0.1\text{A}$, $V_{F(OFF)}$	–	0.1	0.5	V
	^{*10} High level supply current	I_{CCH}	$I_{F(ON)}$	–	2.5	5	mA
	^{*10} Low level supply current	I_{CCL}	$V_{F(OFF)}$	–	2.5	5	mA
	UVLO threshold	V_{UVLO+}	$V_O > 5\text{V}$, $I_F = 10\text{mA}$	11	12.3	13.5	V
		V_{UVLO-}		9.5	10.7	12	V
	UVLO Hysteresis	$UVLO_{HYS}$		–	1.6	–	V
Transfer characteristics	^{*11} "Low→High" threshold input current	I_{FLH}	$V_O > 5\text{V}$, $I_O = 0$	–	–	5	mA
	Isolation resistance	R_{ISO}	$T_a = 25^\circ\text{C}$, $DC = 500\text{V}$, 40 to 60%RH	5×10^{10}	10^{11}	–	Ω
	Response time	"Low→High" propagation time	$R_G = 10\Omega$, $C_G = 10\text{nF}$, $f = 10\text{kHz}$, Duty ratio 50%	0.1	0.3	0.5	μs
		"High→Low" propagation time		0.1	0.3	0.5	μs
		^{*12} Distortion of pulse width		–	–	0.3	μs
		Propagation delay skew		–0.35	–	0.35	μs
		Rise time		–	0.1	–	μs
		Fall time		–	0.1	–	μs
		UVLO Turn on delay	$V_O > 5\text{V}$, $I_F = 10\text{mA}$	–	0.8	–	μs
		UVLO Turn off delay	$V_O > 5\text{V}$, $I_F = 10\text{mA}$	–	0.6	–	μs
	Instantaneous common mode rejection voltage (High level output)	$ CM_H $	$T_a = 25^\circ\text{C}$, $V_{CM} = 1.5\text{kV(p-p)}$, $I_F = 10$ to 16mA , $V_{CC} = 30\text{V}$, $V_{OH} > 15\text{V}$	15	–	–	$\text{kV}/\mu\text{s}$
	Instantaneous common mode rejection voltage (Low level output)	$ CM_L $	$T_a = 25^\circ\text{C}$, $V_{CM} = 1.5\text{kV(p-p)}$, $V_F = 0$, $V_{CC} = 30\text{V}$, $V_{OL} < 1\text{V}$	15	–	–	$\text{kV}/\mu\text{s}$

^{*7} It shall connect a by-pass capacitor of $0.1\mu\text{F}$ or more between V_{CC} (Pin No. 8) and GND (Pin No. 5) near the device, when it measures the transfer characteristics and the output side characteristics.

^{*8} Pulse width $\leq 50\mu\text{s}$, Duty ratio : 0.005

^{*9} Pulse width $\leq 10\mu\text{s}$, Duty ratio : 0.002

^{*10} Output pin is open.

^{*11} I_{FLH} is the value of forward current when output becomes from "L" to "H"

^{*12} Distortion of pulse width $\Delta t_w = |t_{PHL} - t_{PLH}|$

^{*13} All typical values are at $T_a = 25^\circ\text{C}$, $V_{CC} = 30\text{V}$

■ Model Line-up

Lead Form	Through-Hole	SMT Gullwing	Wide SMT Gullwing
Package	Sleeve	Taping	
	50 pcs/sleeve	1 000 pcs/reel	
Model No.	PC925L0NSZ0F	PC925L0NIP0F	PC925L0NUP0F

Fig.1 Test Circuit for High Level Output Current

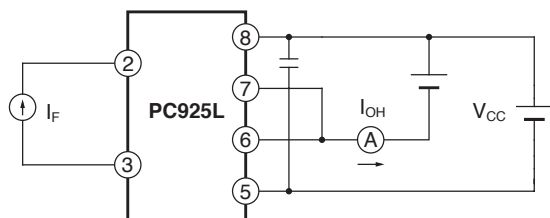


Fig.2 Test Circuit for Low Level Output Current

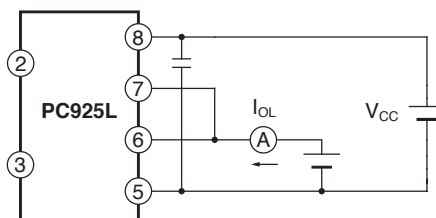


Fig.3 Test Circuit for High Level Output Voltage

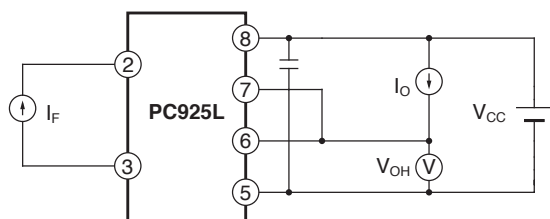


Fig.4 Test Circuit for Low Level Output Voltage

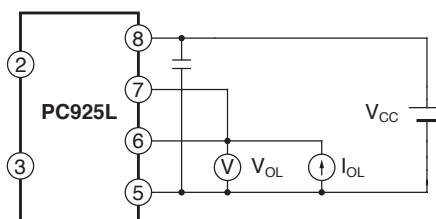


Fig.5 Test Circuit for High Level / Low Level Supply Current

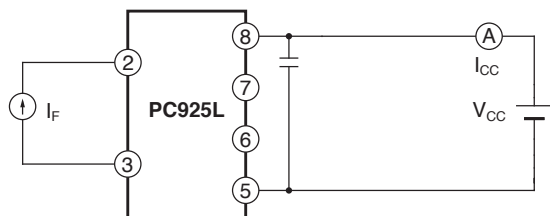


Fig.6 Test Circuit for UVLO Threshold

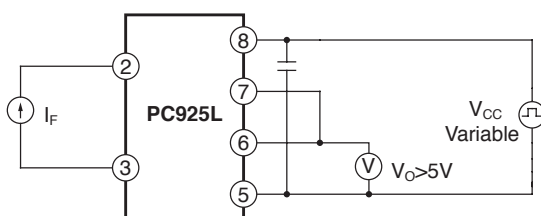


Fig.7 Test Circuit for "Low→High" Input Threshold Current

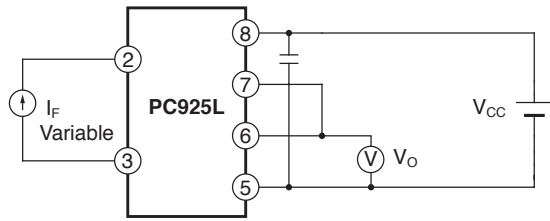


Fig.8 Test Circuit for Response Time

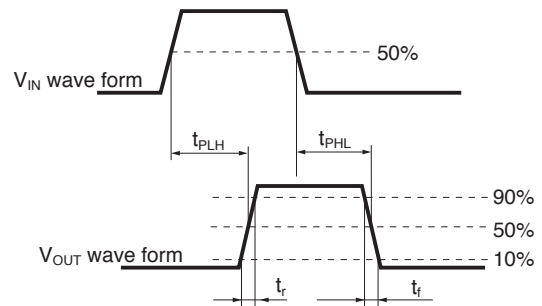
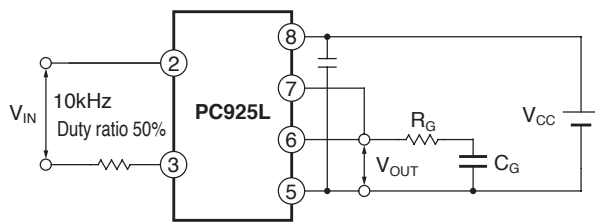


Fig.9 Test Circuit for Instantaneous Common Mode Rejection Voltage

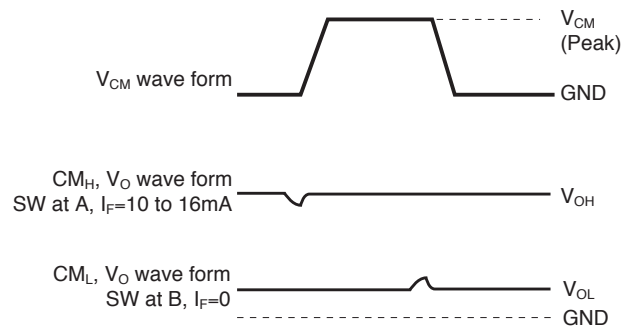
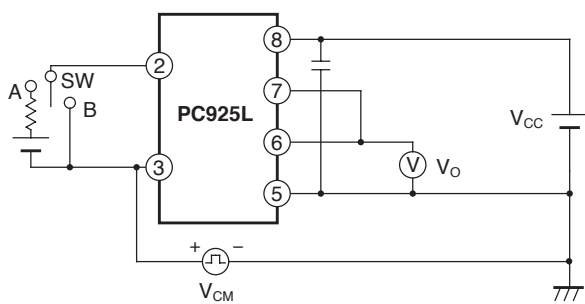


Fig.10 Forward Current vs. Ambient Temperature

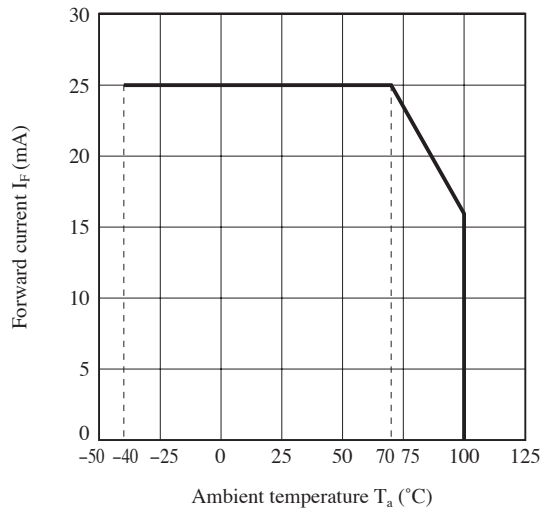


Fig.11 Power Dissipation vs. Ambient Temperature

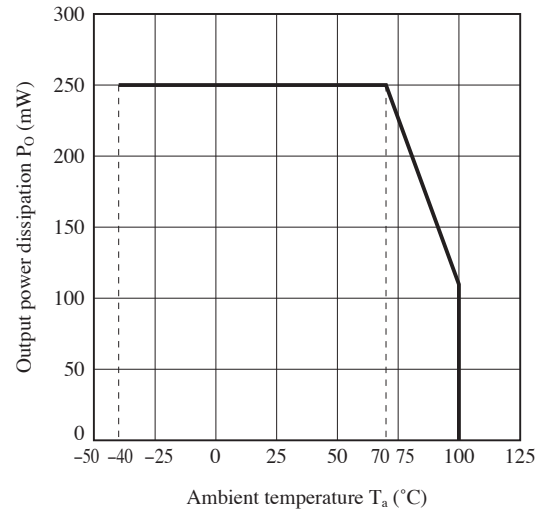


Fig.12 Total Power Dissipation vs. Ambient Temperature

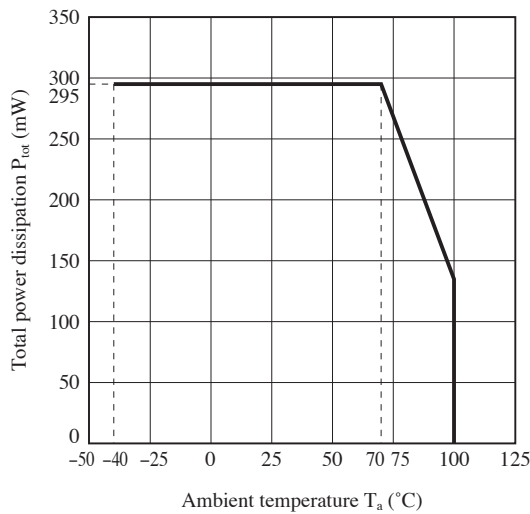


Fig.13 Forward Current vs. Forward Voltage

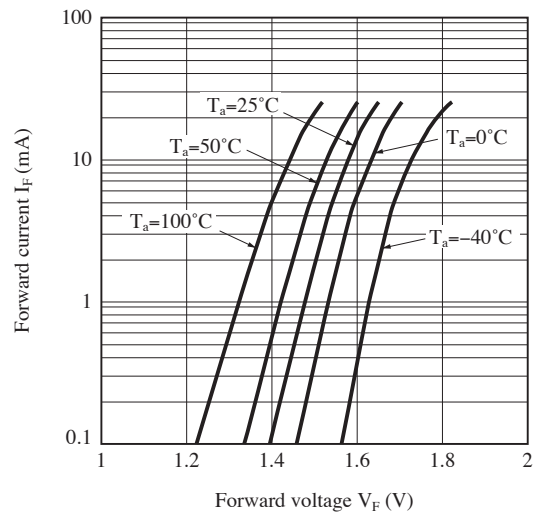


Fig.14 High Level Output Voltage Drop vs. Ambient Temperature

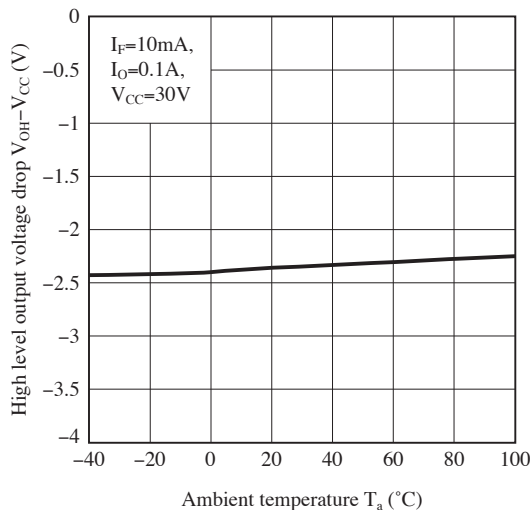


Fig.15 High Level Output Voltage Drop vs. Supply Voltage

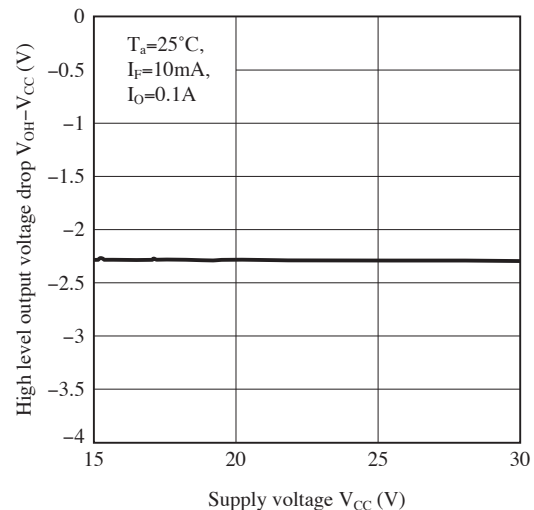


Fig.16 Low Level Output Voltage vs. Ambient Temperature

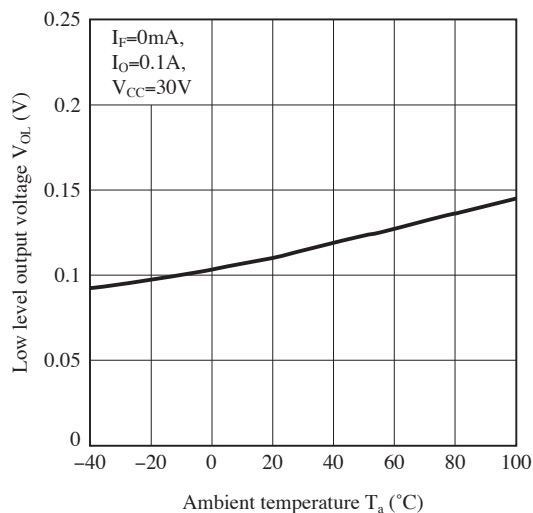


Fig.17 Low Level Output Voltage vs. Supply Voltage

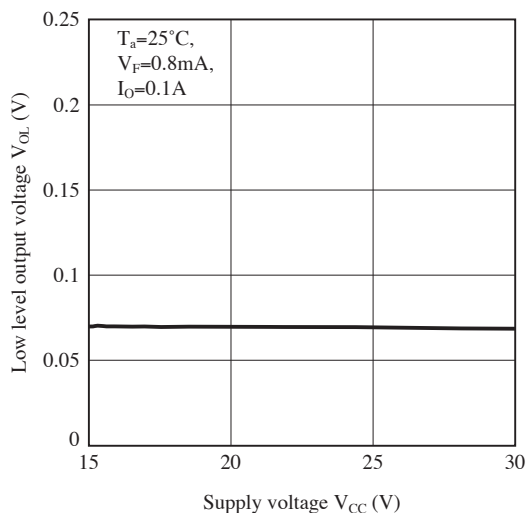


Fig.18 High Level Supply Current vs. Ambient Temperature

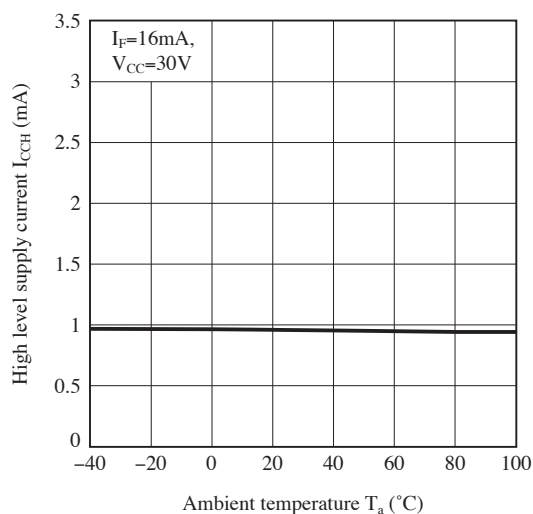


Fig.19 High Level Supply Current vs. Supply Voltage

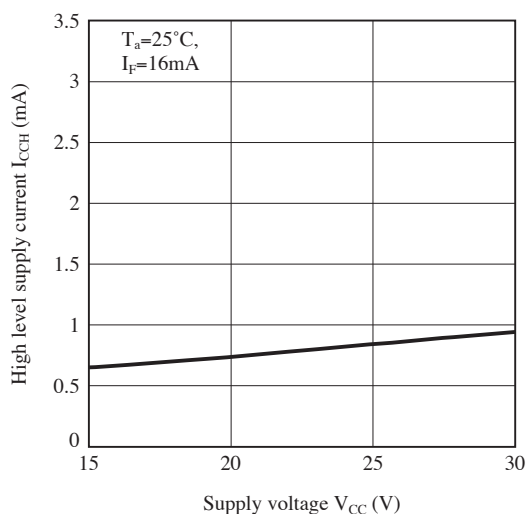


Fig.20 Low Level Supply Current vs. Ambient Temperature

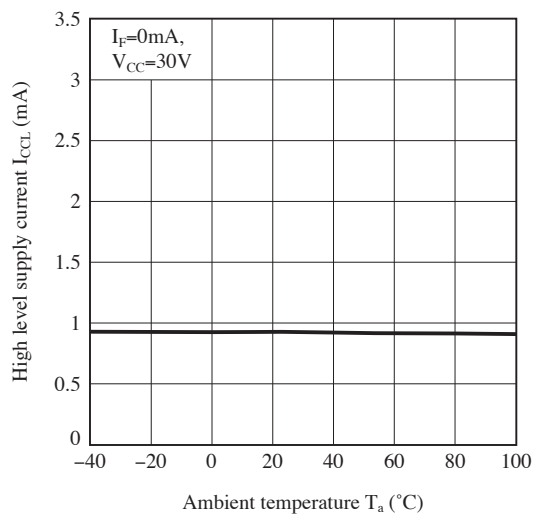


Fig.21 Low Level Supply Current vs. Supply Voltage

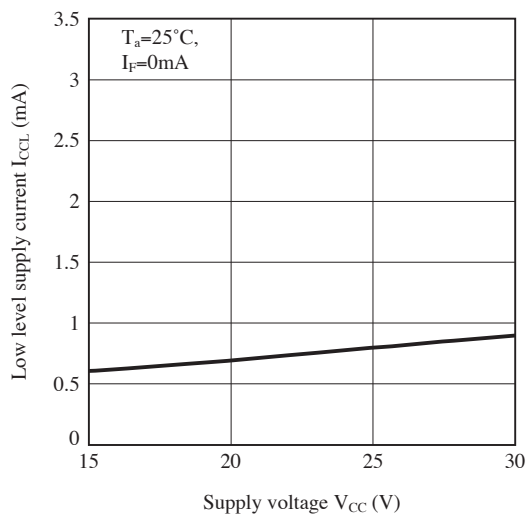


Fig.22 "Low→High" Relative Threshold Input Current vs. Ambient Temperature

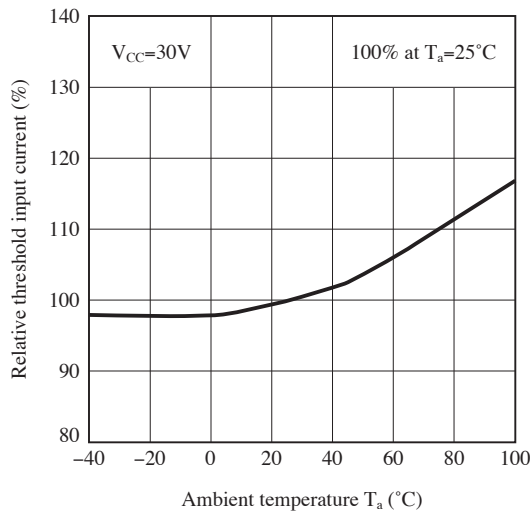


Fig.23 "Low→High" Relative Threshold Input Current vs. Supply Voltage

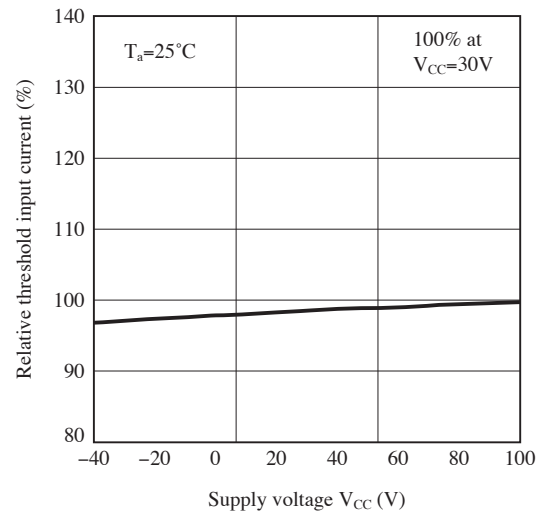


Fig.24 Output Voltage vs. Supply Voltage (UVLO Threshold)

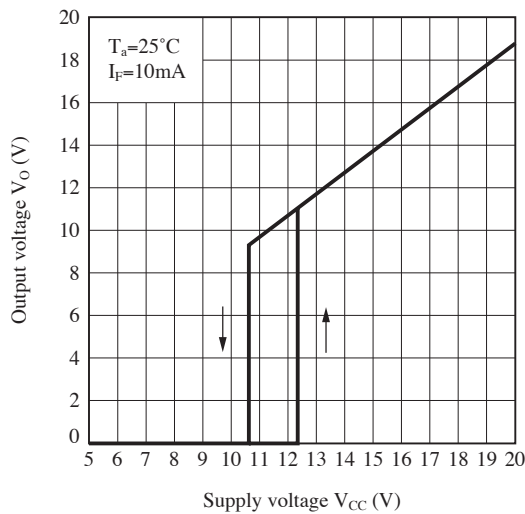


Fig.25 Relative UVLO Threshold vs. Ambient Temperature

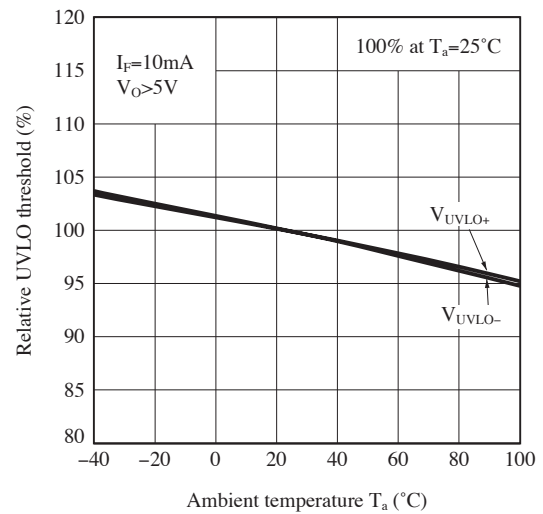
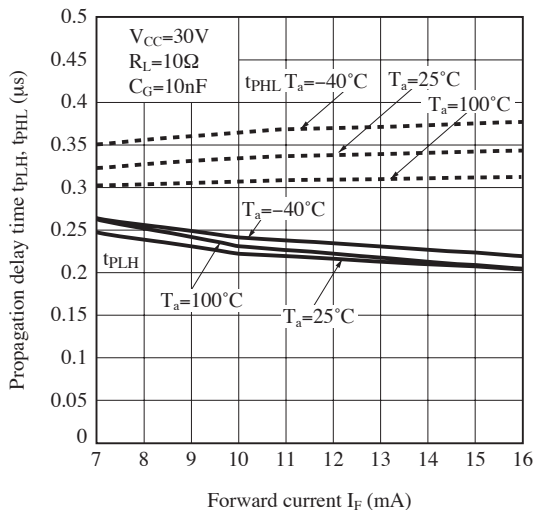


Fig.26 Propagation Delay Time vs. Ambient Temperature



Remarks : Please be aware that all data in the graph are just for reference and not for guarantee.

■ Design Considerations

● Recommended Operating Conditions

Parameter	Symbol	MIN.	MAX.	Unit
Input current (ON)	$I_F(\text{ON})$	7	16	mA
Input voltage (OFF)	$V_F(\text{OFF})$	-3	0.8	V
Supply voltage	V_{CC}	15	30	V
Operating temperature	T_{opr}	-40	100	°C

● Notes about static electricity

Transistor of detector side in bipolar configuration may be damaged by static electricity due to its minute design.

When handling these devices, general countermeasure against static electricity should be taken to avoid breakdown of devices or degradation of characteristics.

● Design guide

In order to stabilize power supply line, please certainly connect a by-pass capacitor of 0.1 μ F or more between V_{CC} and GND near the device.

In case that some sudden big noise caused by voltage variation is provided between primary and secondary terminals of photocoupler some current caused by it is floating capacitance may be generated and result in false operation since current may go through LED or current may change.

If the photocoupler may be used under the circumstances where noise will be generated we recommend to use the bypass capacitors at the both ends of LED.

The detector which is used in this device, has parasitic diode between each pins and GND.

There are cases that miss operation or destruction possibly may be occurred if electric potential of any pin becomes below GND level even for instant.

Therefore it shall be recommended to design the circuit that electric potential of any pin does not become below GND level.

This product is not designed against irradiation and incorporates non-coherent LED.

● Degradation

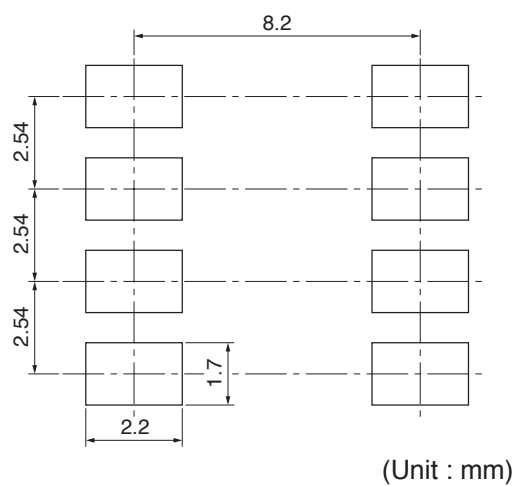
In general, the emission of the LED used in photocouplers will degrade over time.

In the case of long term operation, please take the general LED degradation (50% degradation over 5 years) into the design consideration.

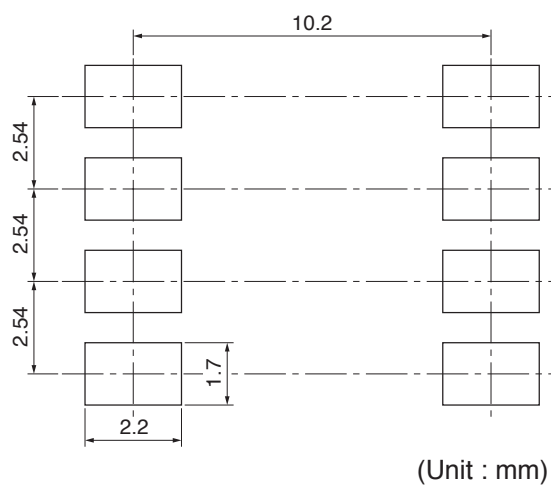
Please decide the input current which become 2 times of MAX. I_{FLH} .

● Recommended Foot Print (reference)

SMT Gullwing Lead-form



Wide SMT Gullwing Lead-form



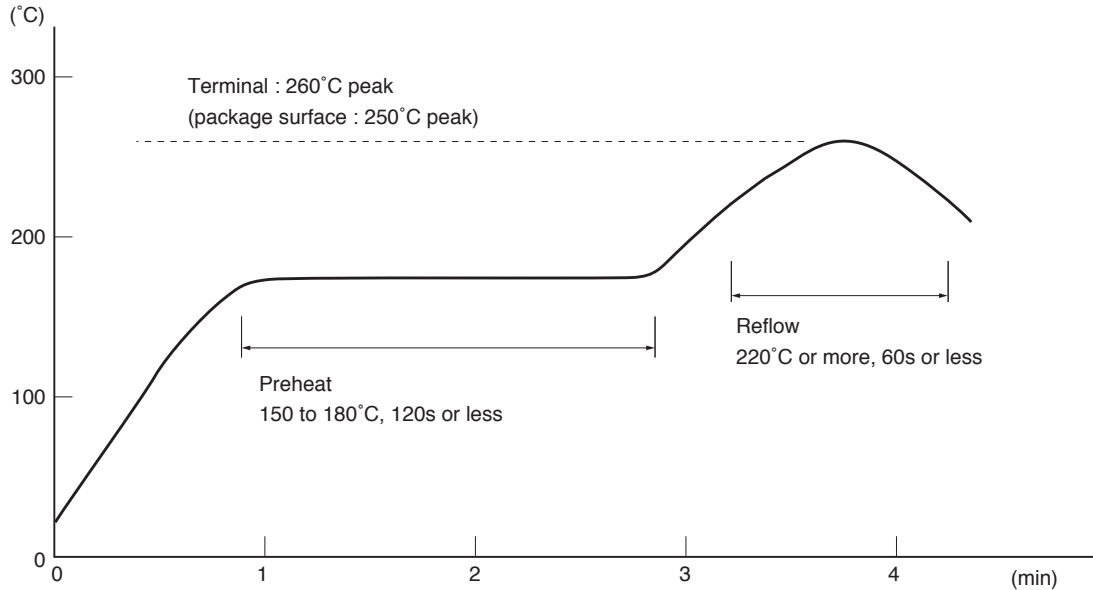
☆ For additional design assistance, please review our corresponding Optoelectronic Application Notes.

■ Manufacturing Guidelines

● Soldering Method

Reflow Soldering :

Reflow soldering should follow the temperature profile shown below.
Soldering should not exceed the curve of temperature profile and time.
Please don't solder more than twice.



Flow Soldering :

Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below 270°C and within 10s.
Preheating is within the bounds of 100 to 150°C and 30 to 80s.
Please don't solder more than twice.

Hand soldering

Hand soldering should be completed within 3 s when the point of solder iron is below 400°C.
Please don't solder more than twice.

Other notice

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.

● Cleaning instructions

Solvent cleaning :

Solvent temperature should be 45°C or below. Immersion time should be 3minutes or less.

Ultrasonic cleaning :

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.

Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

Recommended solvent materials :

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol

In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

● Presence of ODC etc.

This product shall not contain the following materials.

And they are not used in the production process for this product.

Regulation substances : CFCs, Halon, Carbon tetrachloride, 1,1,1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBB and PBDE are not used in this product at all.

- The RoHS directive (2002/95/EC)

This product complies with the RoHS directive (2002/95/EC).

Object substances: lead, mercury, cadmium, hexavalent chromium, polybrominated biphenyls (PBB) and polybrominated diphenyl ethers (PBDE)

- Content of six substances specified in “ Management Methods for Control of Pollution Caused by Electronic Information Products Regulation ” (Chinese : 电子信息产品污染控制管理办法)

Category	Toxic and hazardous substances					
	Lead (Pb)	Mercury (Hg)	Cadmium (Cd)	Hexavalent chromium (Cr(VI))	Polybrominated biphenyls (PBB)	Polybrominated diphenyl ethers (PBDE)
Photocoupler	✓	✓	✓	✓	✓	✓

✓: indicates that the content of the toxic and hazardous substance in all the homogeneous materials of the part is below the concentration limit requirement as described in SJ/T 11363-2006 standard.

■ Package specification

● Sleeve package

Package materials

Sleeve : HIPS (with anti-static material)

Stopper : Styrene-Elastomer

Package method

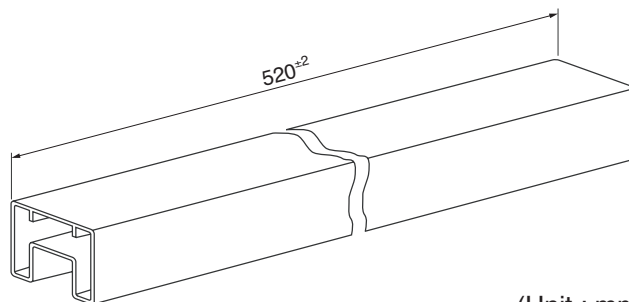
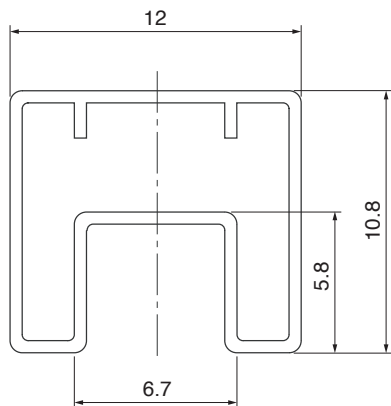
MAX. 50pcs of products shall be packaged in a sleeve.

Both ends shall be closed by tabbed and tabless stoppers.

The product shall be arranged in the sleeve with its anode mark on the tabless stopper side.

MAX. 20 sleeves in one case.

Sleeve outline dimensions



(Unit : mm)

● Tape and Reel package

1. SMT Gullwing Lead-Form

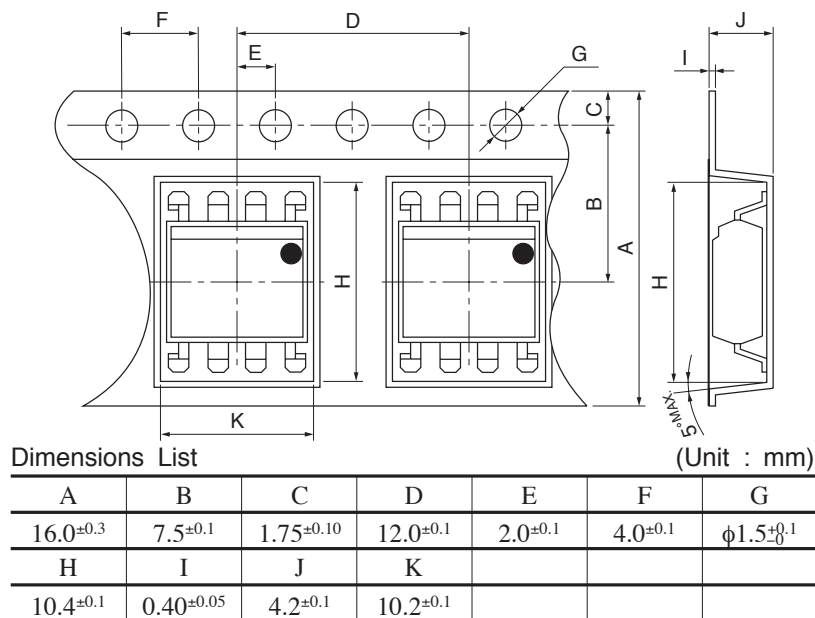
Package materials

Carrier tape : A-PET (with anti-static material)

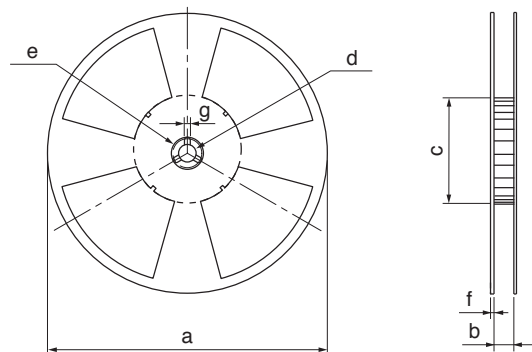
Cover tape : PET (three layer system)

Reel : PS

Carrier tape structure and Dimensions

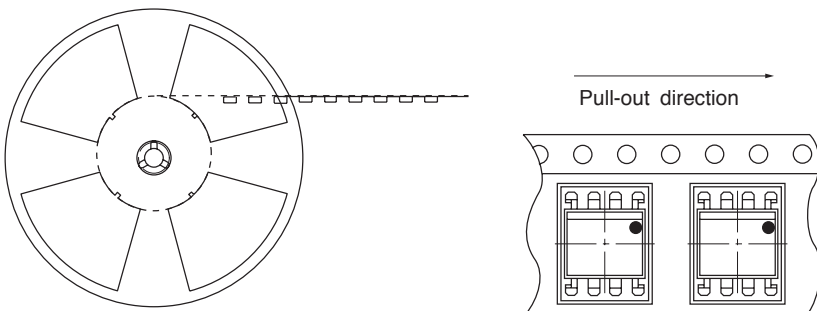


Reel structure and Dimensions



Dimensions List (Unit : mm)			
a	b	c	d
ϕ 330	17.5 $\pm$ 1.5	ϕ 100 $\pm$ 1	ϕ 13.0 $\pm$ 0.5
e	f	g	
ϕ 23 $\pm$ 1	2.0 $\pm$ 0.5	2.0 $\pm$ 0.5	

Direction of product insertion



[Packing : 1 000pcs/reel]

● Tape and Reel package

2. Wide SMT Gullwing Lead-Form

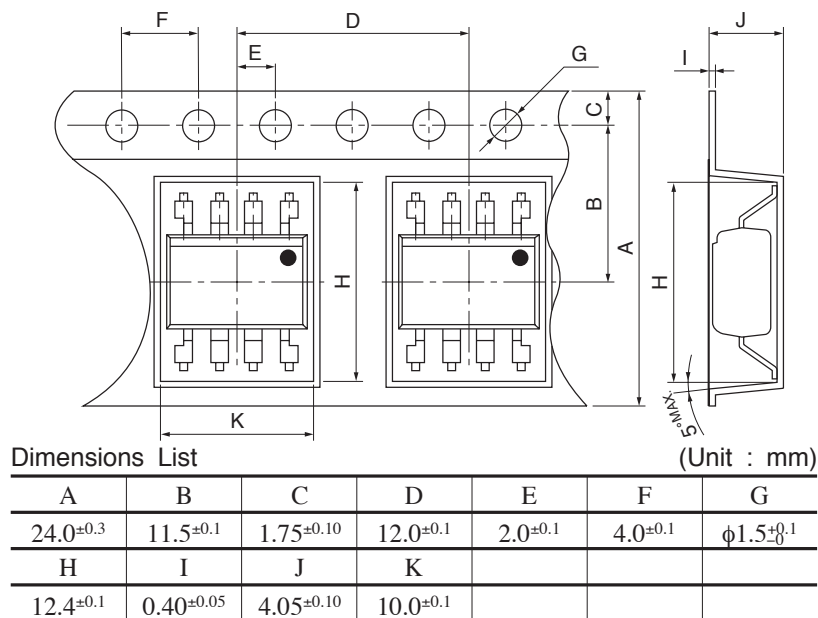
Package materials

Carrier tape : A-PET (with anti-static material)

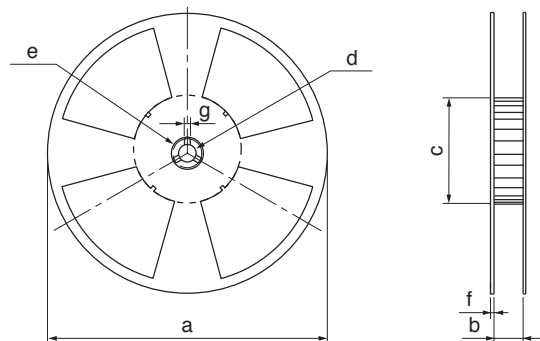
Cover tape : PET (three layer system)

Reel : PS

Carrier tape structure and Dimensions

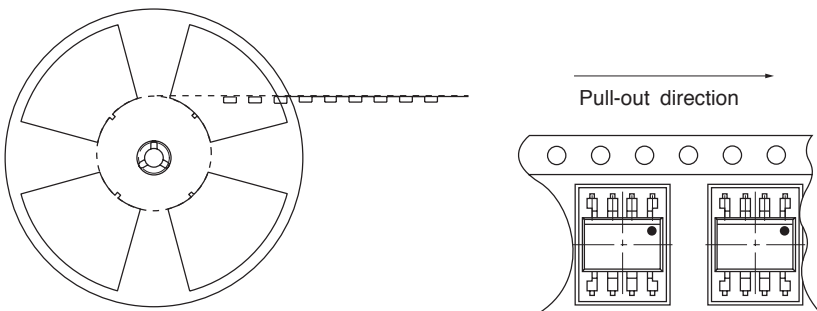


Reel structure and Dimensions



a	b	c	d
φ330	25.5±1.5	φ100±1	φ13.0±0.5
e	f	g	
φ23±1	2.0±0.5	2.0±0.5	

Direction of product insertion



[Packing : 1 000pcs/reel]

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- Industrial control
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- Consumer electronics

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